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October 2014

FDPC8013S

PowerTrench® Power Clip 30 V Asymmetric Dual N-Channel MOSFET

Features

Q1: N-Channel

■ Max $r_{DS(on)} = 9.6 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 10 \text{ A}$

Q2: N-Channel

- Max $r_{DS(on)} = 2.7 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 22 \text{ A}$
- Low inductance packaging shortens rise/fall times, resulting in lower switching losses
- MOSFET integration enables optimum layout for lower circuit inductance and reduced switch node ringing
- RoHS Compliant

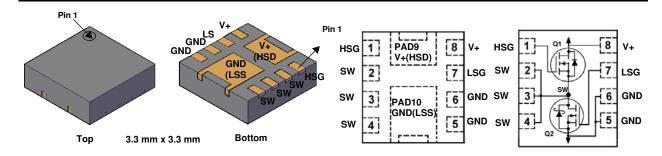


General Description

This device includes two specialized N-Channel MOSFETs in a dual package. The switch node has been internally connected to enable easy placement and routing of synchronous buck converters. The control MOSFET (Q1) and synchronous SyncFETTM (Q2) have been designed to provide optimal power efficiency.

Applications

- Computing
- Communications
- General Purpose Point of Load



MOSFET Maximum Ratings TA = 25 °C unless otherwise noted

Symbol	Parameter		Q1	Q2	Units
V _{DS}	Drain to Source Voltage		30	30	V
V _{GS}	Gate to Source Voltage	(Note 4)	±20	±20	V
	Drain Current -Continuous (Package limited)	T _C = 25 °C	20	55	
I_D	-Continuous	T _A = 25 °C	13 ^{1a}	26 ^{1b}	Α
	-Pulsed		40	100	
E _{AS}	Single Pulse Avalanche Energy	(Note 3)	21	97	mJ
D	Power Dissipation for Single Operation	T _A = 25 °C	1.6 ^{1a}	2.0 ^{1b}	W
P_{D}	Power Dissipation for Single Operation	T _A = 25 °C	0.8 ^{1c}	0.9 ^{1d}	VV
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to	+150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	77 ^{1a}	63 ^{1b}	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	151 ^{1c}	135 ^{1d}	°C/W
R _{e.IC}	Thermal Resistance, Junction to Case	5.0	3.5	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
13CF/15CF	FDPC8013S	Power Clip 33	13 "	12 mm	3000 units

Electrical Characteristics $T_J = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions		Min	Тур	Max	Units
Off Chara	cteristics						
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$ $I_D = 1 \text{ mA}, V_{GS} = 0 V$	Q1 Q2	30 30			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μA, referenced to 25 °C I_D = 10 mA, referenced to 25 °C	Q1 Q2		16 20		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V V _{DS} = 24 V, V _{GS} = 0 V	Q1 Q2			1 500	μ Α μ Α
I _{GSS}	Gate to Source Leakage Current, Forward	V _{GS} = 20 V, V _{DS} = 0 V V _{GS} = 20 V, V _{DS} = 0 V	Q1 Q2			100 100	nA nA

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$ $V_{GS} = V_{DS}, I_D = 1 mA$	Q1 Q2	1.2 1.2	1.5 1.7	3.0 3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_{.1}}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25 °C I _D = 10 mA, referenced to 25 °C	Q1 Q2		-5 -6		mV/°C
	Drain to Source On Resistance	V _{GS} = 10 V, I _D = 13 A V _{GS} = 4.5 V, I _D = 10 A V _{GS} = 10 V, I _D = 13 A,T _J = 125 °C	Q1		4.6 6.7 6.6	6.4 9.6 9.2	m0
r _{DS(on)}	Drain to Source On Resistance	V _{GS} = 10 V, I _D = 26 A V _{GS} = 4.5 V, I _D = 22 A V _{GS} = 10 V, I _D = 26 A ,T _J =125 °C	Q2		1.4 2.0 1.9	1.9 2.7 2.6	- mΩ
9 _{FS}	Forward Transconductance	$V_{DS} = 5 \text{ V}, I_{D} = 13 \text{ A}$ $V_{DS} = 5 \text{ V}, I_{D} = 26 \text{ A}$	Q1 Q2		53 168		S

Dynamic Characteristics

C _{iss}	Input Capacitance	Q1: V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHZ	Q1 Q2	827 2785	pF
C _{oss}	Output Capacitance	Q2:	Q1 Q2	333 997	pF
C _{rss}	Reverse Transfer Capacitance	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHZ}$	Q1 Q2	44 128	pF
R_g	Gate Resistance		Q1 Q2	0.5 0.5	Ω

Switching Characteristics

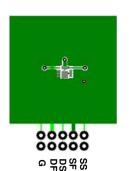
t _{d(on)}	Turn-On Delay Time			Q1 Q2	6 11	ns
t _r	Rise Time	Q1: V _{DD} = 15 V, I _D = 13	3 A, R _{GEN} = 6 Ω	Q1 Q2	2 5	ns
t _{d(off)}	Turn-Off Delay Time	Q2: V _{DD} = 15 V, I _D = 26	SA Boou - 60	Q1 Q2	16 30	ns
t _f	Fall Time	VDD = 13 V, 10 = 20	7 A, NGEN - 0 32	Q1 Q2	2 4	ns
Qg	Total Gate Charge	V _{GS} = 0 V to 10 V		Q1 Q2	13 44	nC
Qg	Total Gate Charge	V _{GS} = 0 V to 4.5 V	V _{DD} = 15 V, I _D = 13 A	Q1 Q2	6 21	nC
Q _{gs}	Gate to Source Gate Charge		Q2 V _{DD} = 15 V,	Q1 Q2	2.2 7.2	nC
Q _{gd}	Gate to Drain "Miller" Charge		$I_D = 26 \text{ A}$	Q1 Q2	1.9 6.6	nC

Electrical Characteristics $T_J = 25$ °C unless otherwise noted

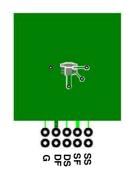
Symbol	Parameter	lest Conditions	туре	Win	тур	wax	Units
Drain-Sou	rce Diode Characteristics						
V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 13 \text{ A}$ (Note 2) $V_{GS} = 0 \text{ V}, I_S = 26 \text{ A}$ (Note 2)			0.80	1.2	V
			Q2		0.77	1.2	
t _{rr}	Reverse Recovery Time	Q1 I _F = 13 A, di/dt = 100 A/μs	Q1 Q2		22 29		ns
Q _{rr}	Reverse Recovery Charge	Q2 $I_F = 26 \text{ A}, \text{ di/dt} = 300 \text{ A/}\mu\text{s}$	Q1 Q2		7 30		nC

Notae:

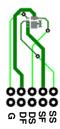
 $1.R_{\theta,JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta,JC}$ is guaranteed by design while $R_{\theta,CA}$ is determined by the user's board design.



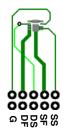
a. 77 °C/W when mounted on a 1 in² pad of 2 oz copper



b. 63 °C/W when mounted on a 1 in² pad of 2 oz copper



c. 151 °C/W when mounted on a minimum pad of 2 oz copper



d. 135 °C/W when mounted on a minimum pad of 2 oz copper

- 2 Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0%.
- 3. Q1 :EAS of 21 mJ is based on starting $T_J = 25$ °C; N-ch: L = 1.2 mH, $I_{AS} = 6$ A, $V_{DD} = 23$ V, $V_{GS} = 10$ V. 100% test at L= 0.1 mH, $I_{AS} = 14.5$ A. Q2: EAS of 97 mJ is based on starting $T_J = 25$ °C; N-ch: L = 0.6 mH, $I_{AS} = 18$ A, $V_{DD} = 23$ V, $V_{GS} = 10$ V. 100% test at L= 0.1 mH, $I_{AS} = 32.9$ A.
- $4. \ As \ an \ N\text{-ch device}, \ the \ negative} \ V_{gs} \ \ rating \ is \ for \ low \ duty \ cycle \ pulse \ occurrence \ only. \ No \ continuous \ rating \ is \ implied.$

Typical Characteristics (Q1 N-Channel) T_J = 25 °C unless otherwise noted

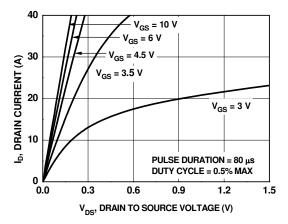


Figure 1. On Region Characteristics

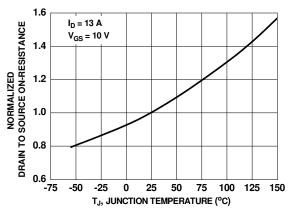


Figure 3. Normalized On Resistance vs Junction Temperature

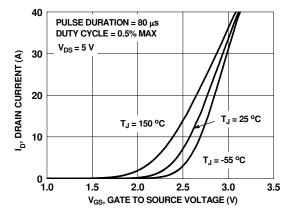


Figure 5. Transfer Characteristics

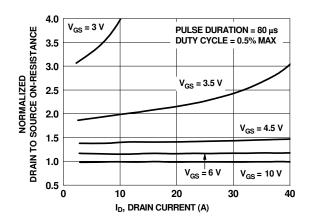


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

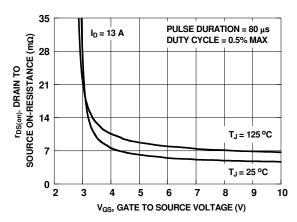


Figure 4. On-Resistance vs Gate to Source Voltage

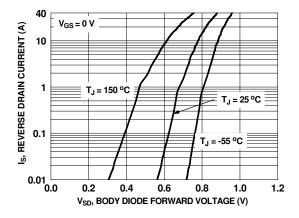


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics (Q1 N-Channel) T_J = 25 °C unless otherwise noted

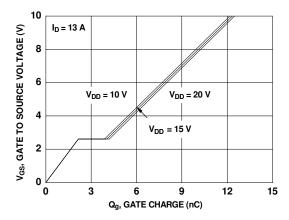


Figure 7. Gate Charge Characteristics

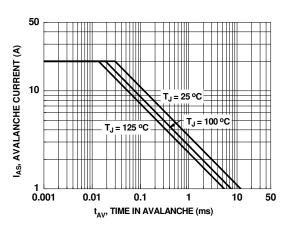


Figure 9. Unclamped Inductive Switching Capability

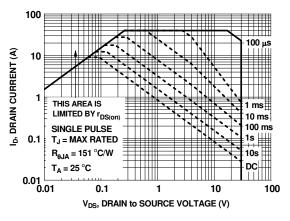


Figure 11. Forward Bias Safe Operating Area

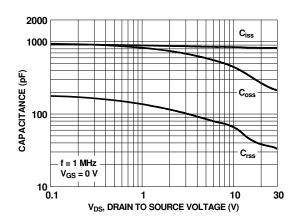


Figure 8. Capacitance vs Drain to Source Voltage

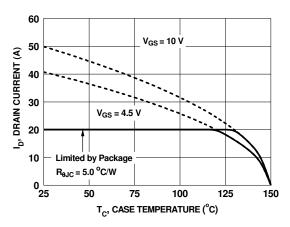


Figure 10. Maximum Continuous Drain Current vs. Ambient Temperature

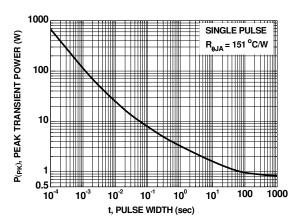


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics (Q1 N-Channel) T_J = 25 °C unless otherwise noted

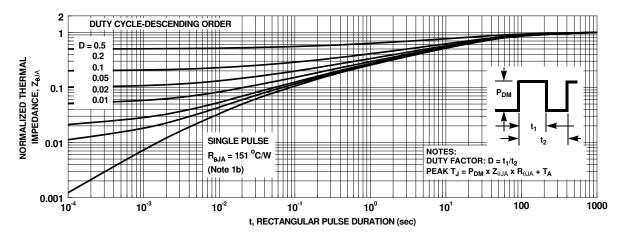


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

Typical Characteristics (Q2 N-Channel) T_J = 25 °C unlenss otherwise noted

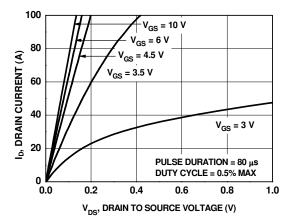


Figure 14. On-Region Characteristics

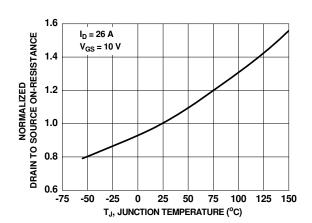


Figure 16. Normalized On-Resistance vs Junction Temperature

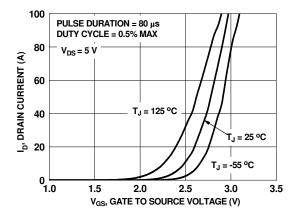


Figure 18. Transfer Characteristics

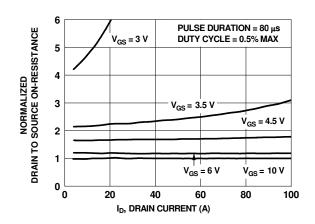


Figure 15. Normalized on-Resistance vs Drain Current and Gate Voltage

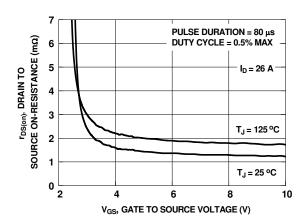


Figure 17. On-Resistance vs Gate to Source Voltage

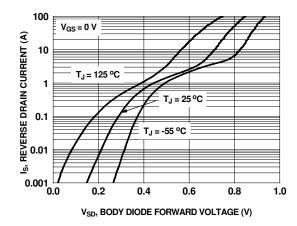


Figure 19. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics (Q2 N-Channel) $T_J = 25$ °C unlenss otherwise noted

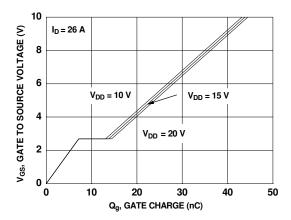


Figure 20. Gate Charge Characteristics

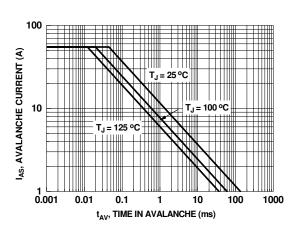


Figure 22. Unclamped Inductive Switching Capability

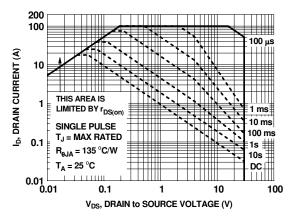


Figure 24. Forward Bias Safe Operating Area

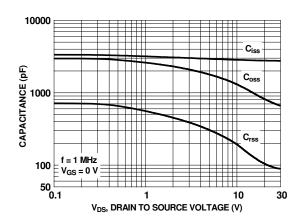


Figure 21. Capacitance vs Drain to Source Voltage

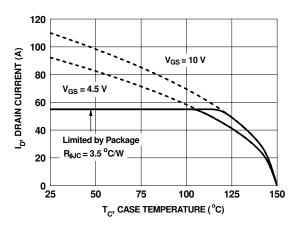


Figure 23. Maximum Continouns Drain Current vs Ambient Temperature

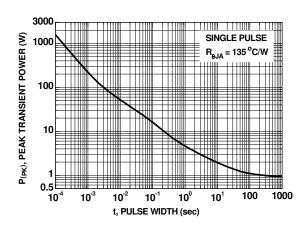


Figure 25. Single Pulse Maximum Power Dissipation

Typical Characteristics (Q2 N-Channel) $T_J = 25$ °C unlenss otherwise noted

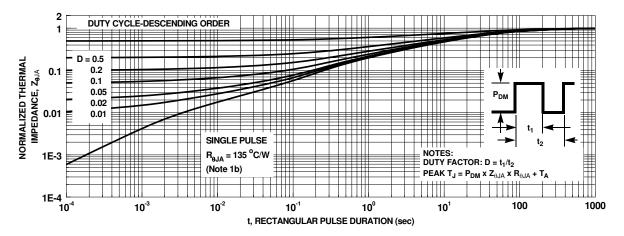


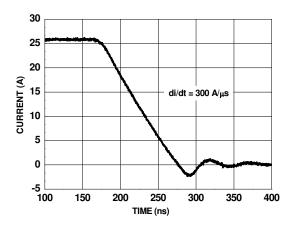
Figure 26. Junction-to-Ambient Transient Thermal Response Curve

Typical Characteristics (continued)

SyncFETTM Schottky body diode Characteristics

Fairchild's SyncFETTM process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 27 shows the reverse recovery characteristic of the FDPC8013S.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.



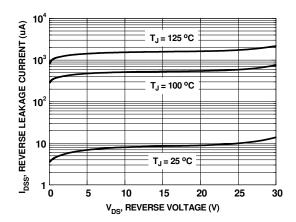
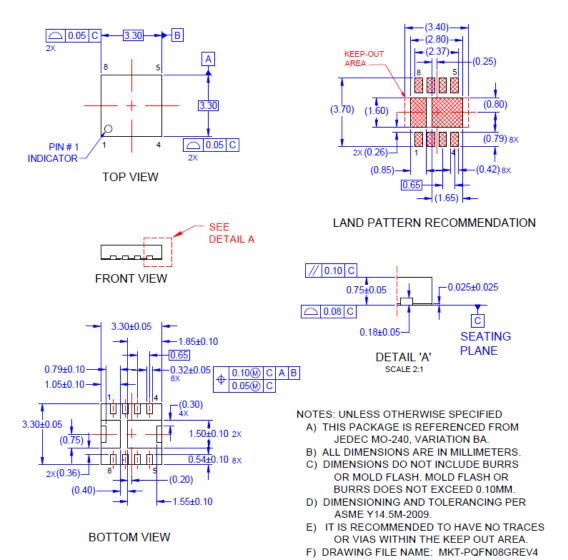


Figure 27. FDPC8013S SyncFETTM body diode reverse recovery characteristic

Figure 28. SyncFETTM body diode reverse leakage versus drain-source voltage

Dimensional Outline and Pad Layout





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Datasheet Identification	Product Status	Definition
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No Identification Needed Full Production		Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

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